

**Search Notes**

Application/Control No.

10/650,336

Examiner

Y. Lee

Applicant(s)/Patent under  
Reexamination

KAWA ET AL.

Art Unit

2621

**SEARCHED**

Class	Subclass	Date	Examiner
375	240.01 240.13 240.21 240.25 **	1/11/2007	YL
	240.26		
H04N	7/12		
update	search	5/2/2007	YL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
375	240.25	5/2/2007	YL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR.